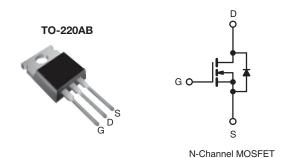


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	200			
$R_{DS(on)}(\Omega)$	V _{GS} = 5.0 V 0.80			
Q _g (Max.) (nC)	16			
Q _{gs} (nC)	2.7			
Q _{gd} (nC)	9.6			
Configuration	Single			



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- Fast Switching
- · Ease of paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Load (Dh) froe	IRL620PbF
Lead (Pb)-free	SiHL620-E3
SnPb	IRL620
SIFD	SiHL620

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	200		
Gate-Source Voltage			V _{GS}	± 10	V	
Continuous Drain Current	V _{GS} at 5.0 V	T _C = 25 °C	I _D	5.2		
Continuous Drain Current	V _{GS} at 5.0 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$		3.3	Α	
Pulsed Drain Current ^a			I _{DM}	21		
Linear Derating Factor				0.40	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	125	mJ	
Repetitive Avalanche Current ^a			I _{AR}	5.2	Α	
Repetitive Avalanche Energya			E _{AR}	5.0	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	50	W	
Peak Diode Recovery dV/dtc			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d] [
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 6.9 mH, $R_q = 25 \Omega$, $I_{AS} = 5.2 \text{ A}$ (see fig. 12c).
- c. $I_{SD} \le 5.2 \text{ A}$, $dV/dt \le 120 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	2.5			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	V, I _D = 250 μA	200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I _D = 1 mA	-	0.27	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_0$	_{GS} , I _D = 250 μA	1.0	-	2.0	V
Gate-Source Leakage	I _{GSS}	Vo	$V_{GS} = \pm 10$		-	± 100	nA
Zero Gate Voltage Drain Current		V _{DS} = 200 V, V _{GS} = 0 V		-	-	25	
zero Gate voltage Drain Current	I _{DSS}	V _{DS} = 160 V, V	_{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 5.0 V	I _D = 3.1 A ^b	-	-	0.80	Ω
	, ,	V _{GS} = 4.0 V	I _D = 2.6 A ^b	-	-	1.0	
Forward Transconductance	g _{fs}	V _{DS} = 50	0 V, I _D = 3.1 A ^b	1.2	-	-	S
Dynamic							
Input Capacitance	C_{iss}	V	_{GS} = 0 V,	1	360	-	
Output Capacitance	C_{oss}	V _D	$V_{GS} = 0.5$, $V_{DS} = 25 \text{ V}$, f = 1.0 MHz, see fig. 5		91	-	pF
Reverse Transfer Capacitance	C _{rss}	t = 1.0 ľ			27	-	
Total Gate Charge	Q_g			-	-	16	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V	$I_D = 5.2 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 ^b	-	-	2.7	
Gate-Drain Charge	Q_{gd}		3	1	-	9.6	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 100 \text{ V}, I_{D} = 9.0 \text{ A},$ $R_{g} = 6.0 \Omega, R_{D} = 11 \Omega, \text{ see fig. } 10^{\text{b}}$		-	4.2	-	ns
Rise Time	t _r			-	31	-	
Turn-Off Delay Time	t _{d(off)}			-	18	-	
Fall Time	t _f				17	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from	Between lead, 6 mm (0.25") from		4.5	-	nH
Internal Source Inductance	L _S	package and center of die contact		ı	7.5	-	11111
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		i	-	5.2	Α
Pulsed Diode Forward Current ^a	I _{SM}			ı	-	21	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 5.2 A, V _{GS} = 0 V ^b		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 5.2 A, dl/dt = 100 A/μs ^b		-	180	270	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	1.1	1.7	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

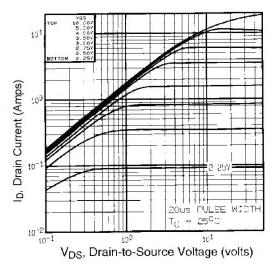


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

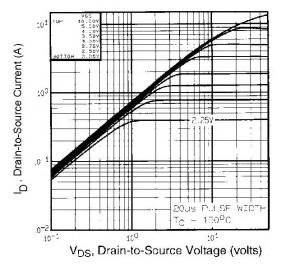


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

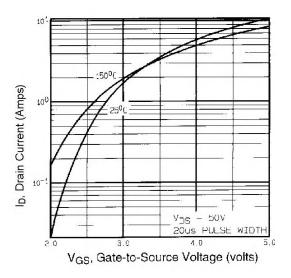


Fig. 3 - Typical Transfer Characteristics

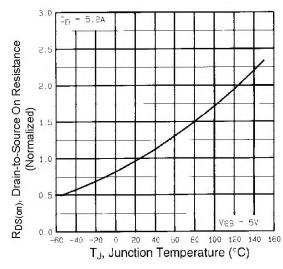


Fig. 4 - Normalized On-Resistance vs. Temperature



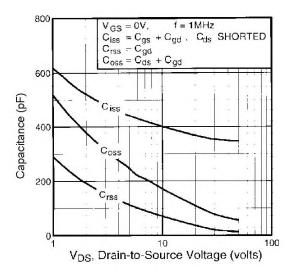


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

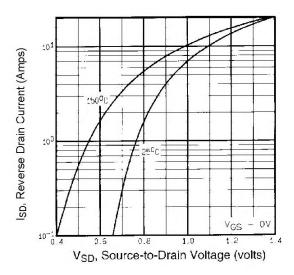


Fig. 7 - Typical Source-Drain Diode Forward Voltage

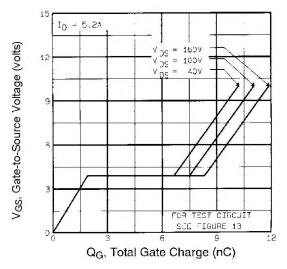


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

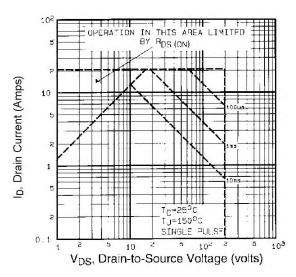


Fig. 8 - Maximum Safe Operating Area





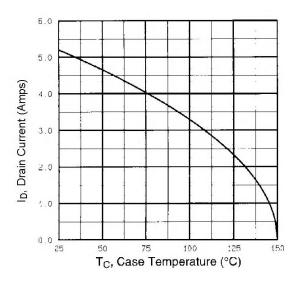


Fig. 9 - Maximum Drain Current vs. Case Temperature

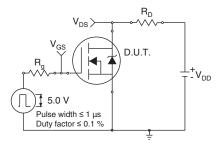


Fig. 10a - Switching Time Test Circuit

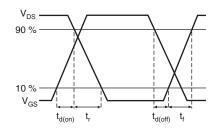


Fig. 10b - Switching Time Waveforms

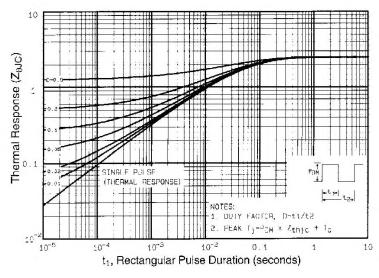
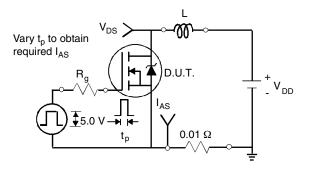


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





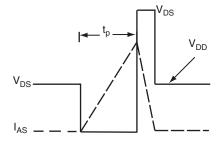


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

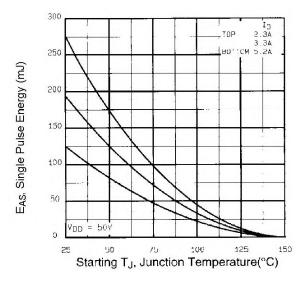


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

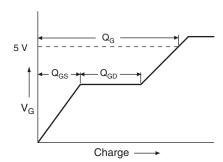


Fig. 13a - Basic Gate Charge Waveform

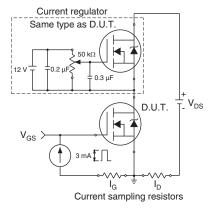
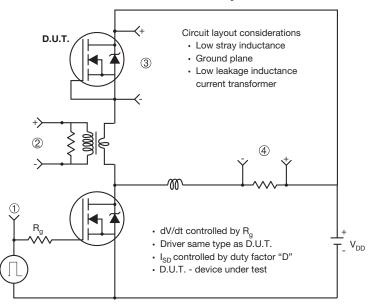


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



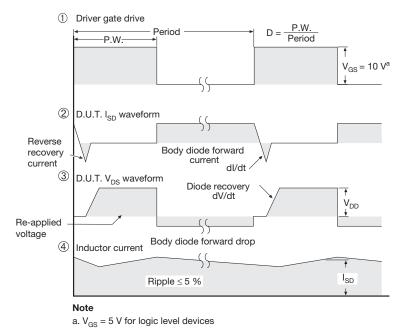


Fig. 14 - For N-Channel

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TO-220-1



DIM.	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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